



QNHCHIP

QN4406AY

Product Specification

QN4406AY

30V N-Channel MOSFET



FEATURES

30V, 13A

$R_{DS(ON)} = 9.5m\Omega @ V_{GS} = 10V$

$R_{DS(ON)} = 14.5m\Omega @ V_{GS} = 4.5V$

Advanced Trench Technology

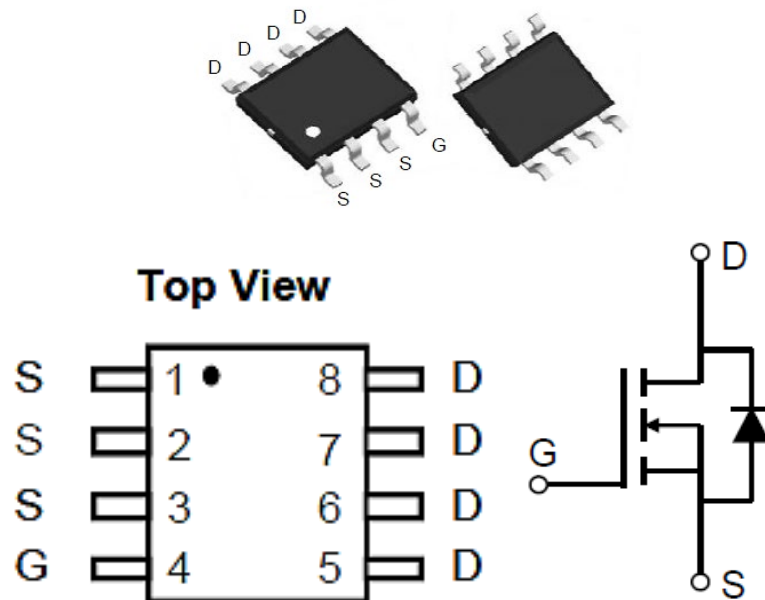
Excellent $R_{DS(ON)}$ and Low Gate Charge

Lead Free

Applications

- Load Switch
- PWM Application
- Power Management

Pin Description



NO.	Symbol	Description
1	S	SOURCE
2	S	SOURCE
3	S	SOURCE
4	G	GATE
5	D	DRAIN
6	D	DRAIN
7	D	DRAIN
8	D	DRAIN



Absolute Maximum Ratings

(@ $T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Units	
V_{DS}	Drain-to-Source Voltage	30	V	
V_{GS}	Gate-to-Source Voltage	± 20	V	
I_D	Continuous Drain Current	$T_A = 25^\circ\text{C}$	13	A
		$T_A = 100^\circ\text{C}$	8	
I_{DM}	Pulsed Drain Current ⁽¹⁾	52	A	
E_{AS}	Single Pulsed Avalanche Energy ⁽²⁾	36	mJ	
P_D	Power Dissipation	$T_A = 25^\circ\text{C}$	1.6	W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	77	$^\circ\text{C}/\text{W}$	
T_J, T_{STG}	Junction & Storage Temperature Range	-55 to 150	$^\circ\text{C}$	



Electrical Characteristics

(T_J=25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V	-	-	1.0	μA
I _{GSS}	Gate-Body Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.2	1.6	2.2	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	V _{GS} =10V, I _D =13A	-	9.5	12	mΩ
		V _{GS} =4.5V, I _D =10A	-	14.5	20	mΩ
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz	-	1002	-	pF
C _{oss}	Output Capacitance		-	131	-	pF
C _{rss}	Reverse Transfer Capacitance		-	105	-	pF
Q _g	Total Gate Charge	V _{GS} =0~10V, V _{DD} =15V, I _D =13A	-	20	-	nC
Q _{gs}	Gate Source Charge		-	4	-	nC
Q _{gd}	Gate Drain("Miller") Charge		-	5	-	nC
Switching Characteristics						
t _{d(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DD} =15V I _D =13A, R _{GEN} =3 Ω	-	6	-	ns
t _r	Turn-On Rise Time		-	19	-	ns
t _{d(off)}	Turn-Off DelayTime		-	22	-	ns
t _f	Turn-Off Fall Time		-	5	-	ns
Drain-Source Diode Characteristics and Max Ratings						
I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	13	A
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	52	A
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} =0V, I _S =13A	-	-	1.2	V
t _{rr}	Body Diode Reverse Recovery Time	I _F =13A, di/dt=100A/μs	-	8	-	ns
Q _{rr}	Body Diode Reverse Recovery Charge		-	2	-	nC

Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
2. E_{AS} condition: Starting T_J=25°C, V_{DD}=15V, V_G=10V, R_G=25 Ω, L=0.5mH, I_{AS}=12A
3. R_{θJA} is measured with the device mounted on a 1 inch² pad of 2oz copper FR4 PCB
4. Pulse Test: Pulse Width ≤ 300us, Duty Cycle ≤ 0.5%.



Typical Performance Characteristics

Figure 1: Output Characteristics

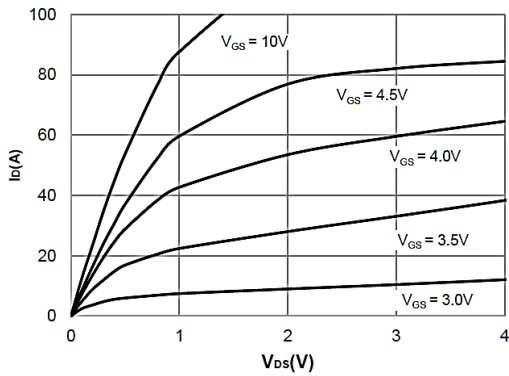


Figure 2: Typical Transfer Characteristics

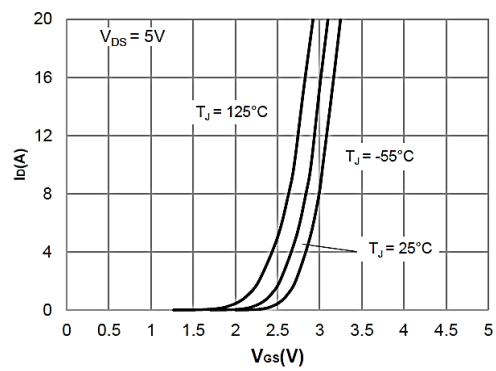


Figure 3: On-resistance vs. Drain Current

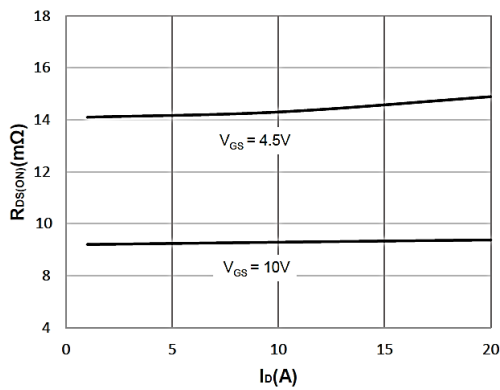


Figure 4: Body Diode Characteristics

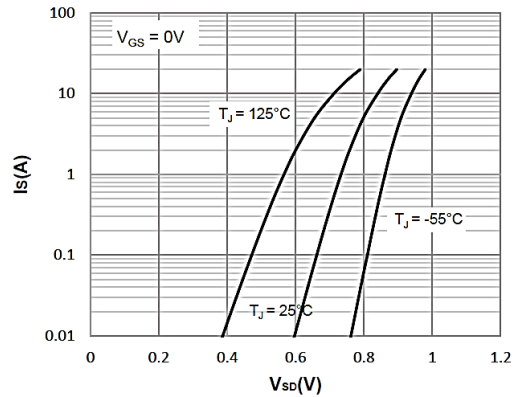


Figure 5: Gate Charge Characteristics

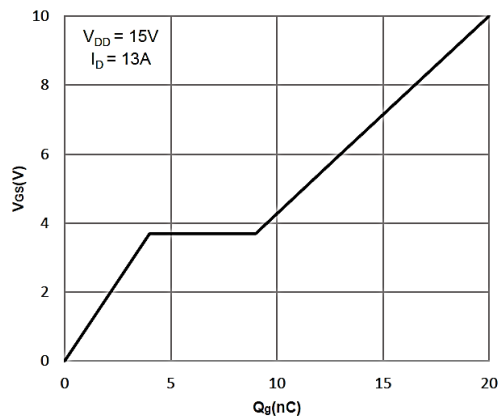


Figure 6: Capacitance Characteristics

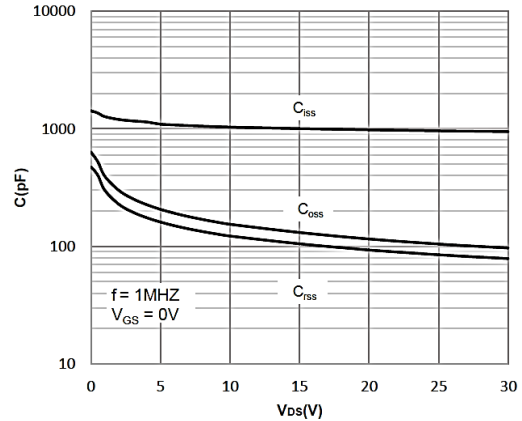


Figure 7: Normalized Breakdown voltage vs. Junction Temperature

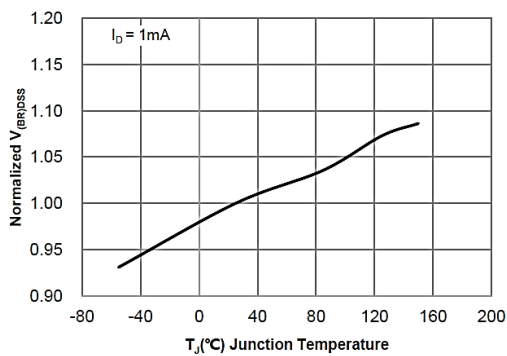


Figure 8: Normalized on Resistance vs. Junction Temperature

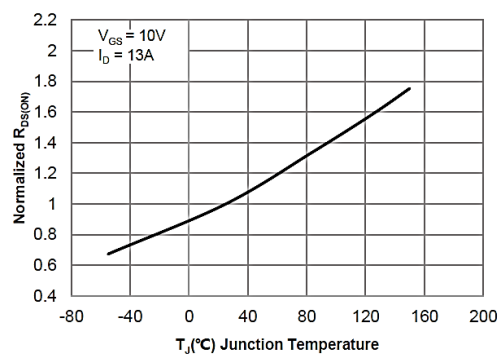




Figure 9: Maximum Safe Operating Area

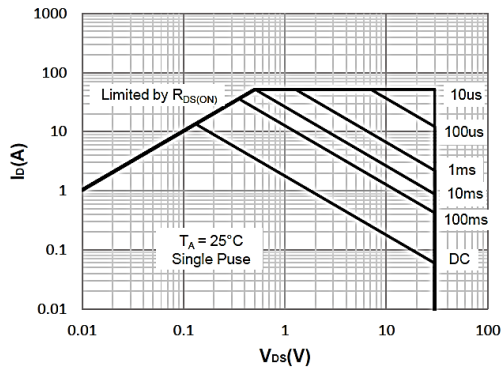


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

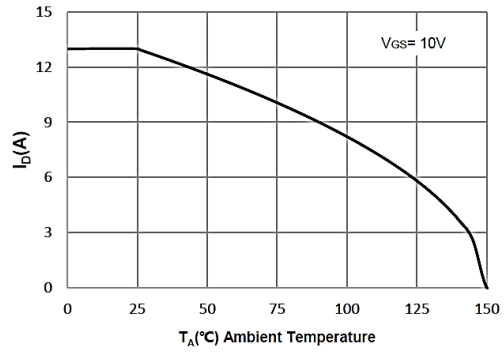


Figure 11: Normalized Maximum Transient Thermal Impedance

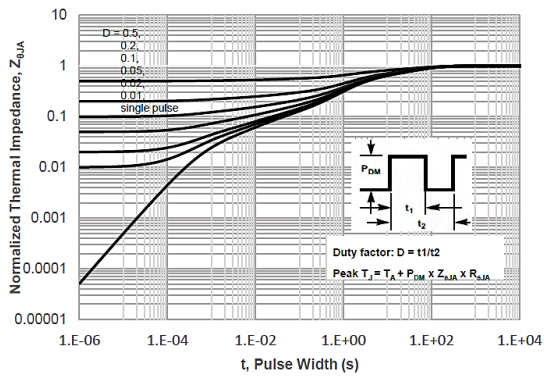
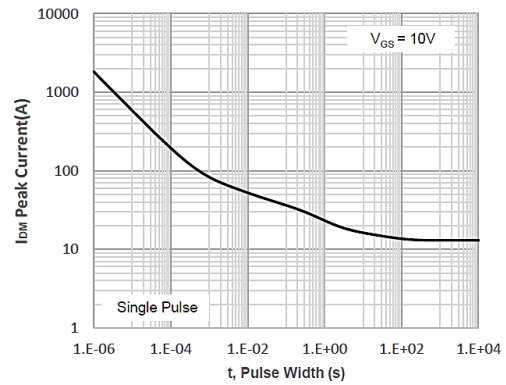


Figure 12: Peak Current Capacity





Test Circuit

Figure 1: Gate Charge Test Circuit & Waveform

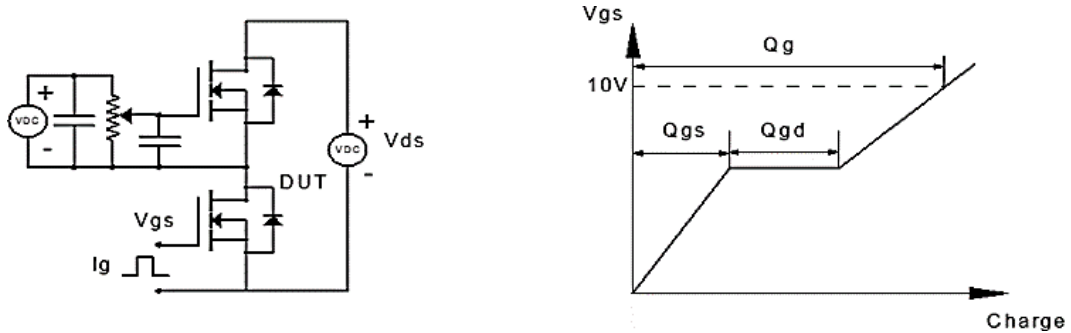


Figure 2: Resistive Switching Test Circuit & Waveform

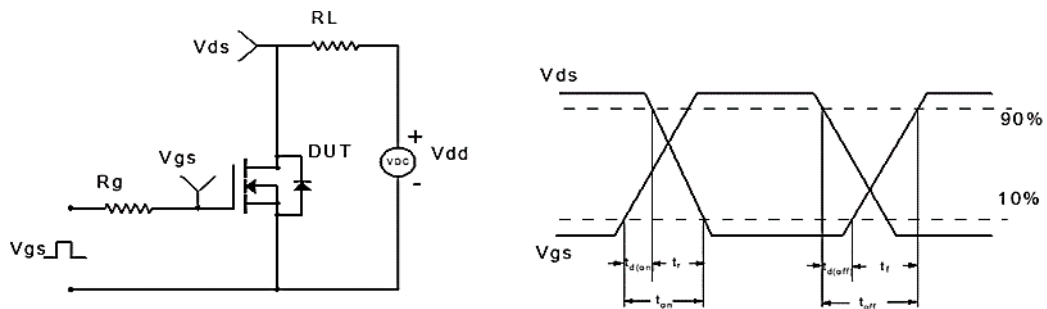


Figure 3: Unclamped Inductive Switching Test Circuit & Waveform

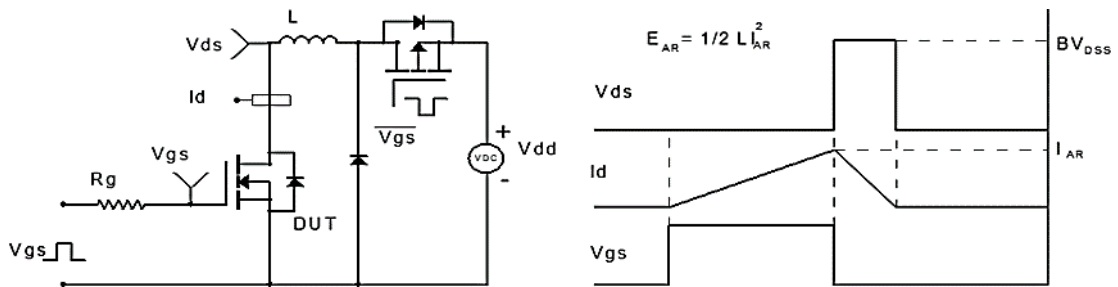
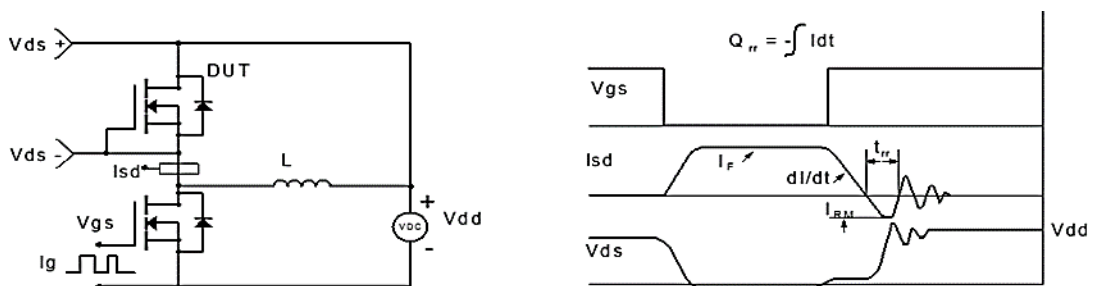


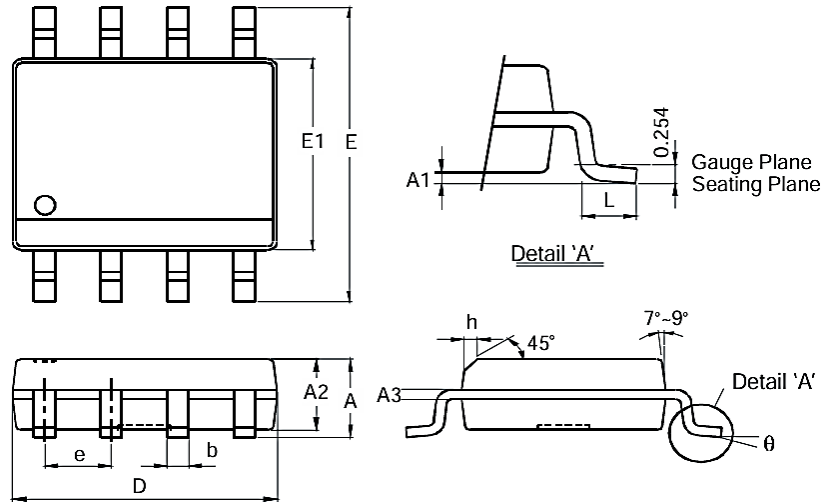
Figure 4: Diode Recovery Test Circuit & Waveform





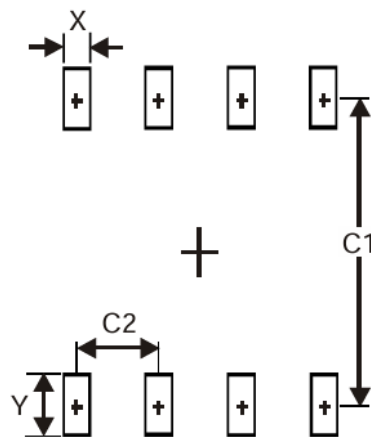
Package Mechanical Data

SOP-8



Dim	Min(mm)	Max(mm)
A	-	1.75
A1	0.10	0.20
A2	1.30	1.50
A3	0.15	0.25
b	0.3	0.5
D	4.85	4.95
E	5.90	6.10
E1	3.85	3.95
e	1.27 Typ	
h	-	0.35
L	0.62	0.82
θ	0°	8°

suggested Pad Layout



Dimensions	Value(mm)
X	0.60
Y	1.55
C1	5.4
C2	1.27



Ordering information

Order Code	Package	V _{DS} (V)	I _D (A)	R _{DS(ON)} (m Ω)	
QN4406AY	SOP-8	30	13	V _{GS} =10V	9.5
				V _{GS} =4.5V	14.5